

N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^a	Q _g (Typ.)			
60	0.078 at V _{GS} = 10 V	3.4	2.1 nC			
	0.089 at V _{GS} = 4.5 V	3.1	2.1110			

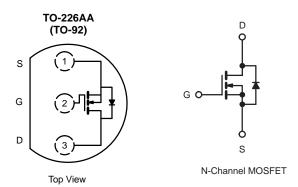
FEATURES

- DT-Trench Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested



APPLICATIONS

- Battery Switch
- DC/DC Converter



ABSOLUTE MAXIMUM RATINGS $T_A = 1$	25 °C, unless oth	erwise noted			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	60	V		
Gate-Source Voltage		V_{GS}			± 20
	T _C = 25 °C		3.4		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	<u> </u>	1.9	۸	
Continuous Diam Current (1) = 130 °C)	T _A = 25 °C	ID	3.1 ^{b, c}		
	T _A = 70 °C		1.8 ^{b, c}		
Pulsed Drain Current		I _{DM}	7	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	T _C = 25 °C	1.49		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	0.91 ^{b, c}		
Avalanche Current		I _{AS}	6	Ì	
Single-Pulse Avalanche Energy L = 0.1		E _{AS}	1.8	mJ	
	T _C = 25 °C	Po	1.66		
Maximum Power Dissipation	T _C = 70 °C		1.06	W	
Maximum Power Dissipation	T _A = 25 °C		1.09 ^{b, c}		
	T _A = 70 °C		0.7 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	≤ 5 s	R_{thJA}	90	115	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	60	75]	

- a. Based on T_C = 25 °C. b. Surface Mounted on 1" x 1" FR4 board.
- d. Maximum under Steady State conditions is 120 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•					•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{DS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			55		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I _D = 250 μA		- 5			
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V			1	μА	
		V _{DS} = 60 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	8			Α	
		$V_{GS} = 10 \text{ V, I}_{D} = 1.9 \text{ A}$		0.075	0.078	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 1.7 \text{ A}$		0.086	0.089		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15V, I _D = 1.9 A		5		S	
Dynamic ^b					L		
Input Capacitance	C _{iss}			180			
Output Capacitance	C _{oss}			22		pF	
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		13			
Total Oats Observe		V _{DS} = 30 V, V _{GS} = 10 V, I _D = 1.9 A		4.2	6.1	nC	
Total Gate Charge	Qg	20 00 2		2.1	3.2		
Gate-Source Charge	Q _{gs}	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1.9 \text{ A}$		0.7			
Gate-Drain Charge	Q_{gd}			1			
Gate Resistance	R _g	f = 1 MHz	0.6	2.2	5.1	Ω	
Turn-On Delay Time	t _{d(on)}			4	6		
Rise Time	t _r	V_{DD} = 30 V, R_L = 20 Ω		10	15	- ns	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 1.5 A, V_{GEN} = 10 V, R_G = 1 Ω		10	15		
Fall Time	t _f			7	10.5		
Turn-On Delay Time	t _{d(on)}			15	23		
Rise Time	t _r	$V_{DD} = 30 \text{ V}, R_1 = 20 \Omega$		16	24	- ns	
Turn-Off Delay Time	t _{d(off)}	$I_D = 1.5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_G = 1 \Omega$		11	17		
Fall Time	t _f			11	17		
Drain-Source Body Diode Characteristic	cs			L			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.19	_	
Pulse Diode Forward Current ^a	I _{SM}				7	- A	
Body Diode Voltage	V_{SD}	I _S = 1.5 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			15	23	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			10	15	nC	
Reverse Recovery Fall Time	t _a	$I_F = 1.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		12		ns	
Reverse Recovery Rise Time	t _b			3			

Notes:

a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %.
b. Guaranteed by design, not subject to production testing.

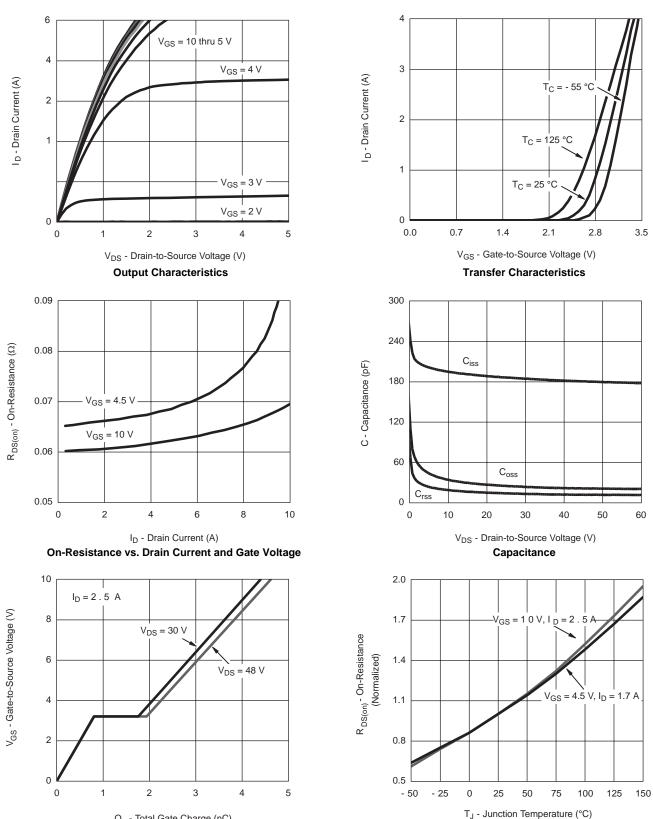
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Q_g - Total Gate Charge (nC)

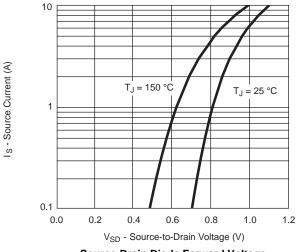
Gate Charge



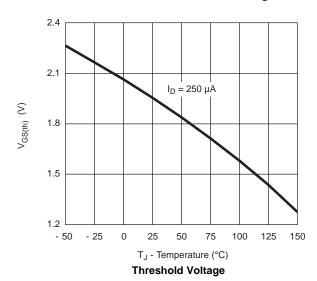
On-Resistance vs. Junction Temperature

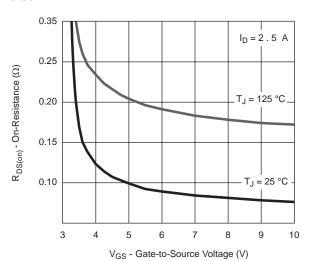


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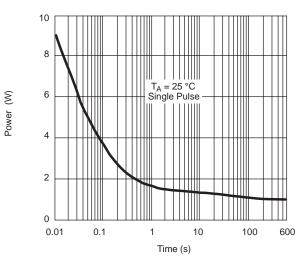


Source-Drain Diode Forward Voltage

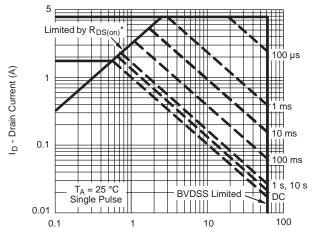




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power



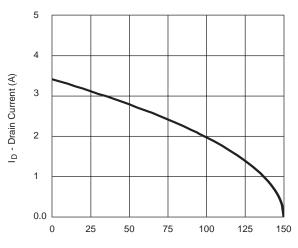
V_{DS} - Drain-to-Source Voltage (V)

Safe Operating Area

^{*} V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

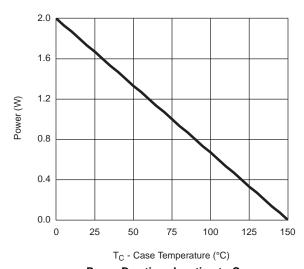


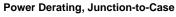
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

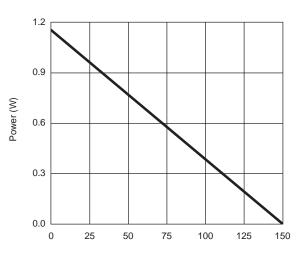


 $T_{\mbox{\scriptsize C}}$ - Case Temperature (°C)

Current Derating*





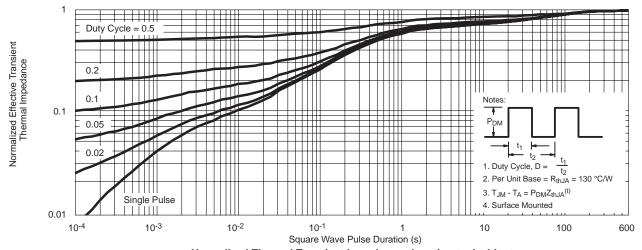


T_A - Ambient Temperature (°C) **Power Derating, Junction-to-Ambient**

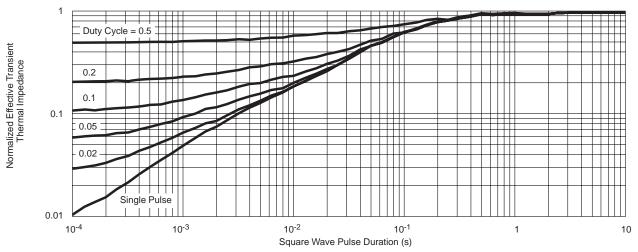
^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot





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